## Search Notes



App	licat	ion/	Cont	trol	N٥
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Applicant(s)/Patent Under Reexamination

MIROKU ET AL.

Examiner

Art Unit

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## **SEARCHED**

Class	Subclass	Date	Examiner
720	620, 606	5/16/2008	MGK
369	30.32	5/16/2008	MGK

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Search Notes	Date	Examiner
EAST (Search History Attached)	5/16/2008	MGK

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner
720	606, 620	5/16/2008	MGK
369	30.32	5/16/2008	MGK

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